

<b>Notice of References Cited</b>	Application/Control No. 10/656,343	Applicant(s)/Patent Under Reexamination SHAN ET AL.	
	Examiner <i>in</i> Tod T. Van Roy	Art Unit 2828	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0193975	10-2003	Pang, Yang	372/25
	B	US-6,700,905	03-2004	Karasawa et al.	372/21
	C	US-			
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**NON-PATENT DOCUMENTS**

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